

Search Notes

Application/Control No.

10/784,714

Examiner

David Y. Chung

Applicant(s)/Patent under
Reexamination

OOI ET AL.

Art Unit

2871

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 349 | 78 | 9/19/2005 | DC |
| 349 | 117 | 9/19/2005 | DC |
| 349 | 120 | 9/19/2005 | DC |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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| same | same | 9/19/2005 | DC |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|-----------|------|
| Text search class 349-see search printout | 9/19/2005 | DC |
| PGPUB text search class 349 (claims only)-see search printout | 9/19/2005 | DC |
| Consulted Ken Parker | 9/19/2005 | DC |
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